

<b>Notice of References Cited</b>	Application/Control No. 09/859,671	Applicant(s)/Patent Under Reexamination WOONHEE ET AL.	
	Examiner Sheila B. Smith	Art Unit 2685	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,405,045	06-2002	Choi et al.	370/229
	B	US-6,381,458	04-2002	Frodigh et al.	455/442
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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